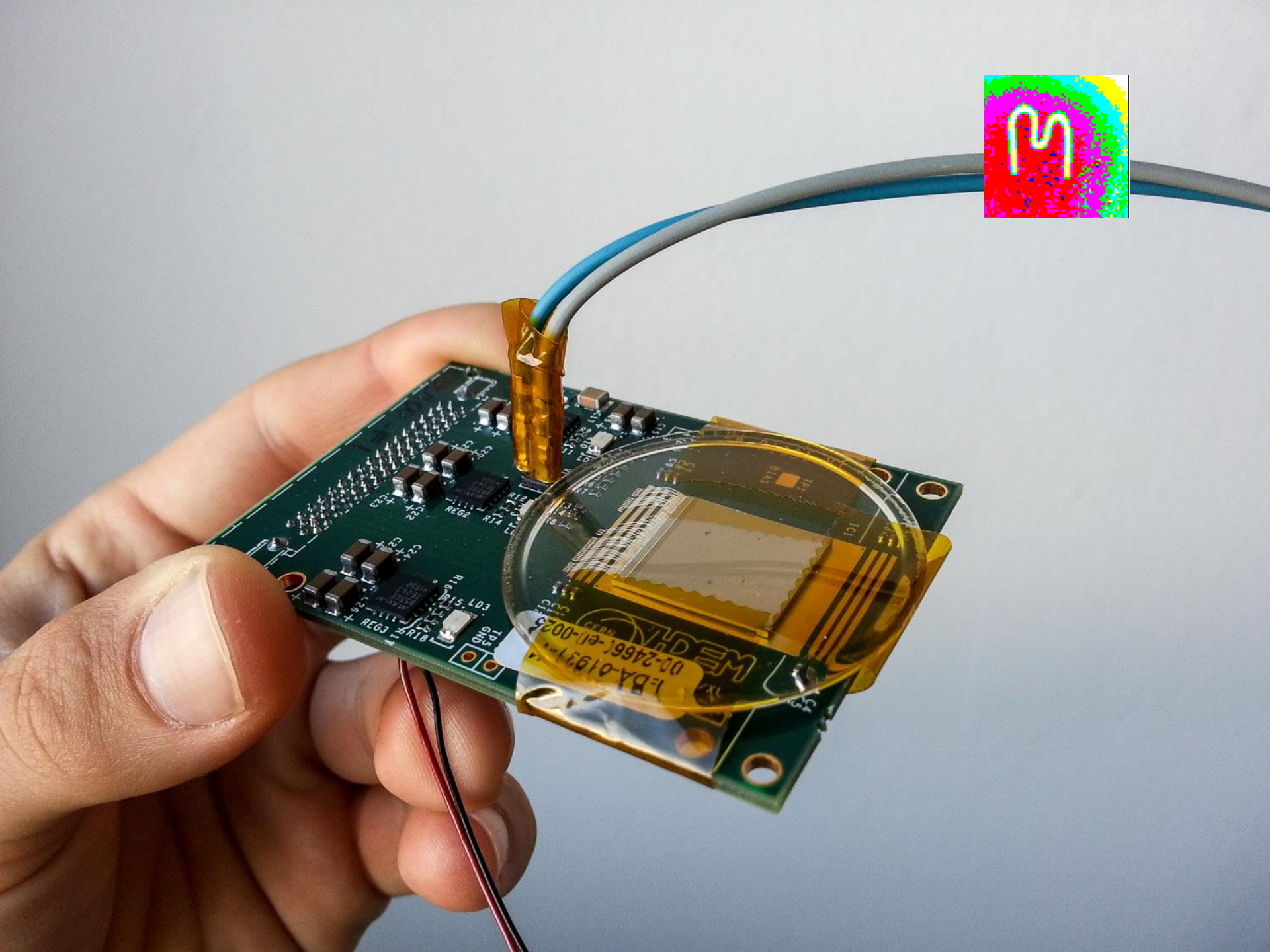


An aerial photograph of a vast, snow-covered mountain range. The peaks are jagged and covered in white snow, with some rocky outcrops visible. The sky is a clear, deep blue. The overall scene is bright and serene.

Erik Fröjdh

CERN, Mid Sweden University



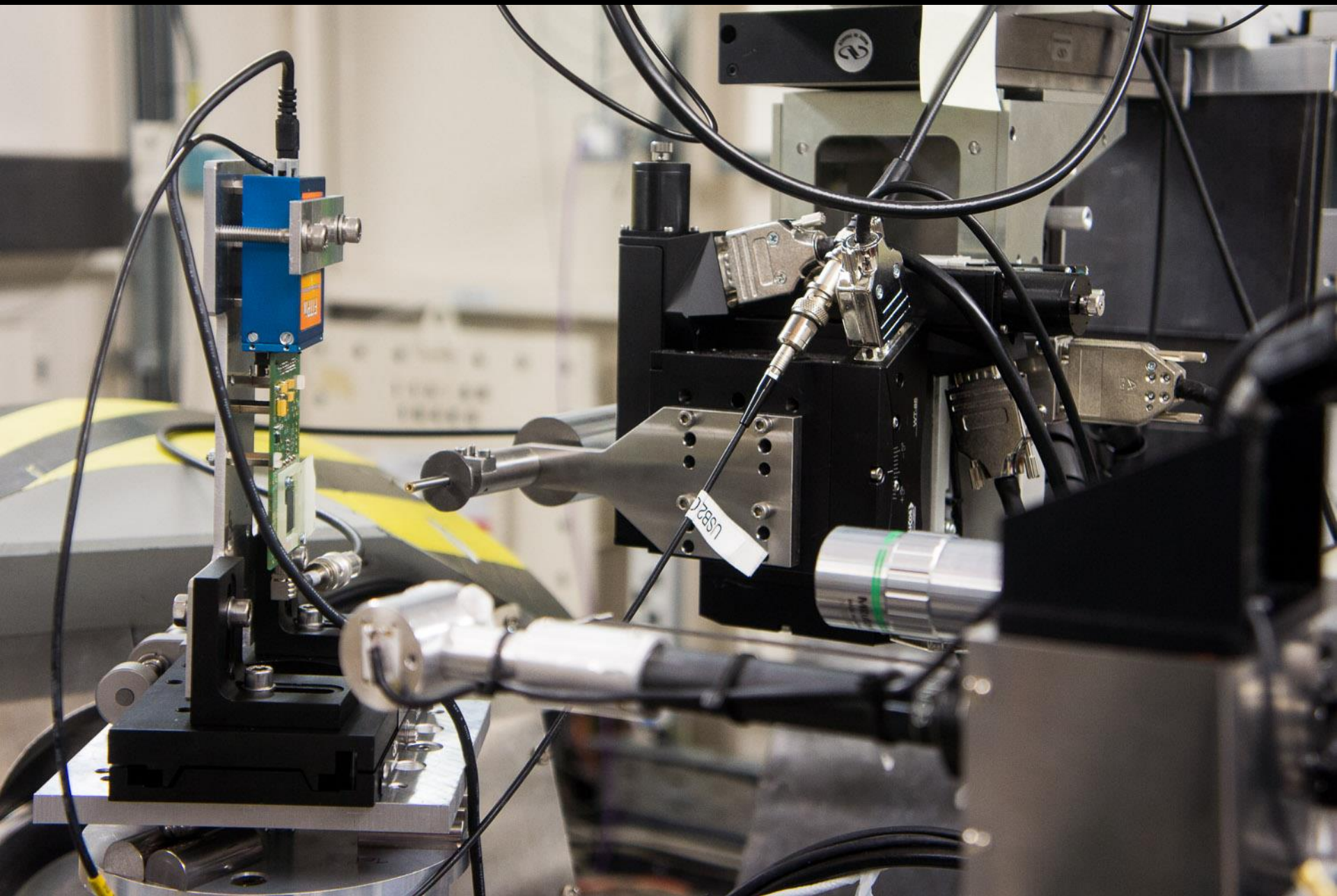


Characterization of hybrid pixel detectors

Applications for dosimetry in mixed radiation fields









Mittuniversitetet

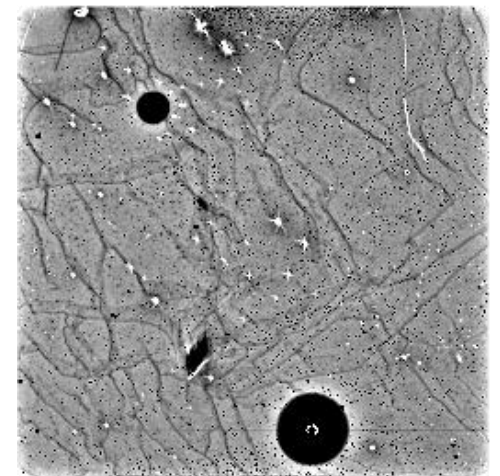
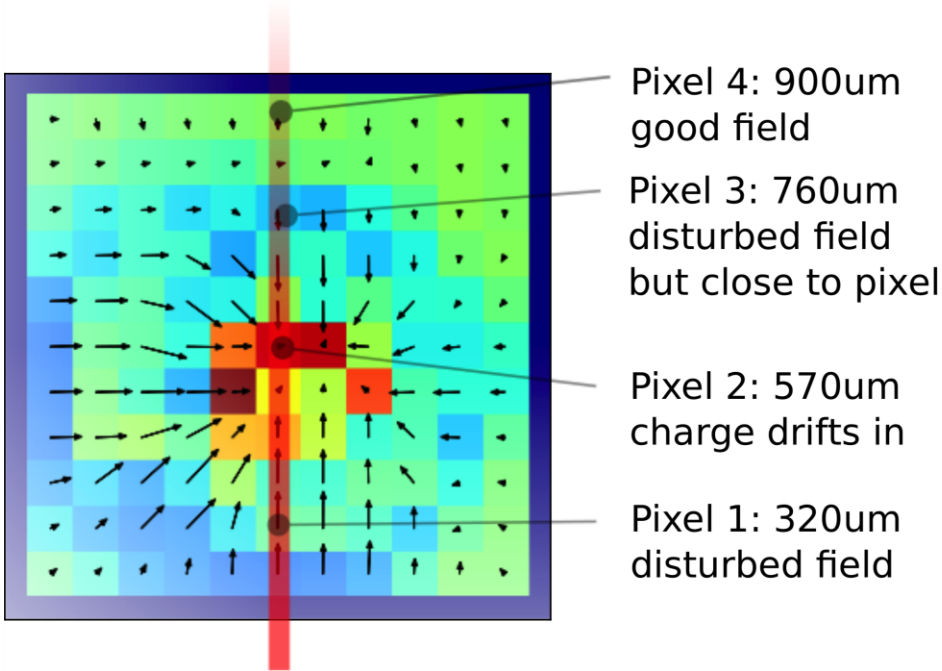
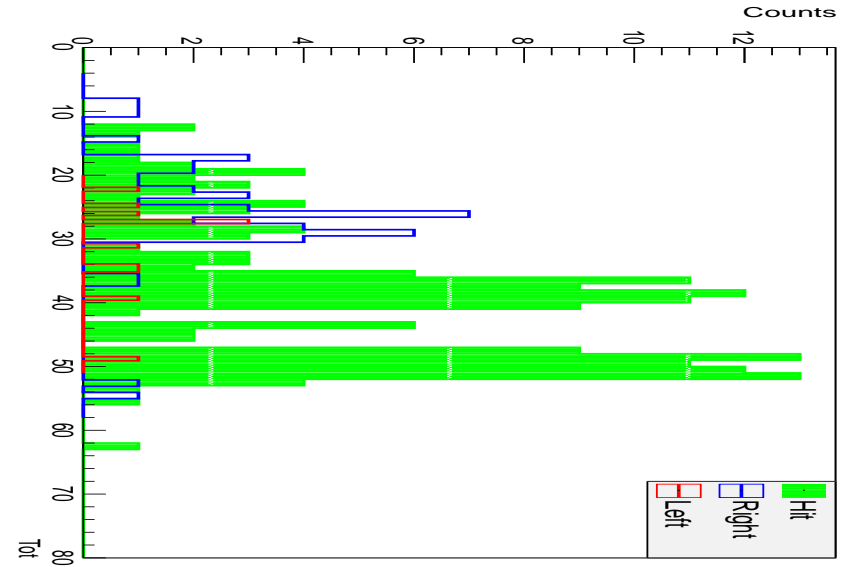
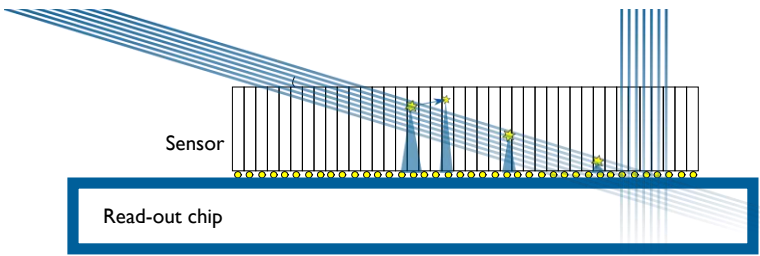
MID SWEDEN UNIVERSITY



University
of Glasgow



diamond







Probing Defects
in a Small Functional Ca²⁺ Sensor Using an Inclined Membrane
X-Ray Micro Beam

Eric Frazier, C. Frazier, D. Krapcho, D. Mancoske,
S. Neeley, V.O. Shwa, H. Wilham, R. Terzani, G.
Thompson, R. H. Zan

The Parker Laboratory, 10700 University Blvd., University of California, San Diego, CA 92037

MacBook Air

Probing Defects

in a Small Pixelated CdTe Sensor Using an Inclined Mono Energetic X-Ray Micro Beam

Erik Fröjd^{1,2}, C. Fröjd¹, E. N. Gimenez⁴, D. Krapohl¹,
D. Maneuski³, B. Norlin¹, V.O'Shea³, H. Wilhelm⁴, N.
Tartoni⁴, G. Thungström⁴, R. M. Zain³

¹Mid Sweden University ²CERN ³Glasgow University ⁴Diamond Light Source
Oct 31 2012, R-10, RTSD



Probing Defects in a Small Pixelated CdTe Sensor Using an Inclined Mono Energetic X-Ray Micro Beam

Erik Fröjd^{1,4} Member, IEEE, C. Fröjd¹ Member, IEEE, E.N. Gimenez³, D. Krapohl¹ Member, IEEE, D. Maneuski², B. Norlin¹, V.O'Shea², H. Wilhelm³, N. Tartoni³, G. Thungström¹, R. M. Zain²

Abstract—High quantum efficiency is important in X-ray imaging applications. This means using high-Z sensor materials. Unfortunately many of these materials suffer from defects that cause non-ideal charge transport. In order to increase the understanding of these defects, we have mapped the 3D response of a number of defects in two 1 mm thick CdTe sensors with different pixel sizes (55 μ m and 110 μ m) using a monoenergetic microbeam at 79 keV. The sensors were bump bonded to Timepix read out chips. Data was collected in photon counting as well as time-over-threshold mode. The time-over-threshold mode is a very powerful tool to investigate charge transport properties and fluorescence in pixelated detectors since the signal from the charge that each photon deposits in each pixel can be analyzed. Results show distorted electrical field around the defects, indications of excess leakage current and large differences in behavior between electron collection and hole collection mode. The experiments were carried out on the Extreme Conditions Beamline I15 at Diamond Light Source.

I. INTRODUCTION

IN order to achieve high quantum efficiency in hard X-ray imaging, there is a need to use high-Z detector materials. GaAs has sometimes been proposed as a medium-Z material [1], [2], [3] but Cadmium Telluride (CdTe) and Cadmium Zinc Telluride (CZT) are the two main candidates that have been investigated since the early 1970s. However, despite recent progress [4], [5], these materials suffer from defects such as twins, sub-grain boundaries, dislocations and inclusions that cause non-ideal charge transport [6], [7], [8].

CdTe detectors are mainly made from crystals grown using methods as the Modified Bridgman method [9] or the Travelling Heater Method [10] but also some attempts to grow polycrystalline layers have been made [11]. The grown crystals are characterized using destructive and non destructive methods

Most of the detector development work concerns single pad detectors or detectors with large pixels [21], [22], [23] where a main problem was the difference in charge collection between electrons and holes. However, recently, CdTe detectors with pixel sizes down to 55 x 55 μ m² have been fabricated and mounted on pixelated readout chips [24]. With that pixel size the small pixel effect largely makes the device a single carrier device and the resolution approaches the resolution of other characterization methods.

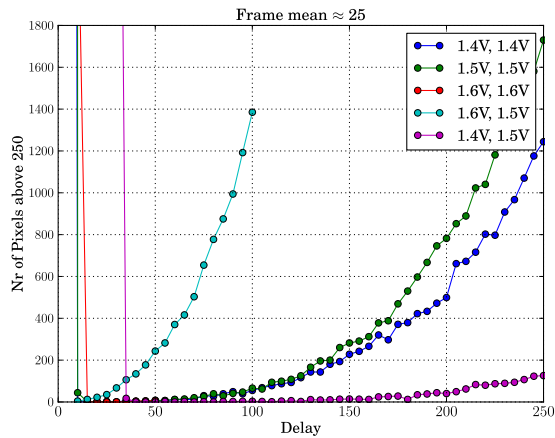
In this project several defects on pixelated CdTe detectors with pixel sizes of 55 x 55 μ m² and 110 x 110 μ m² have been probed with a monoenergetic microbeam. The results are compared to similar measurements made on small pixel detectors and to results obtained using other characterization methods.

II. MEASUREMENT SETUP

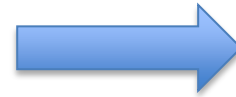
The measurements were carried out at the I15 Extreme Conditions Beamline at Diamond Light Source [25]. For the measurements we used two different types of CdTe sensors bump-bonded to Timepix readout chips. The sensors had pixel sizes of 55 x 55 μ m² and 110 x 110 μ m². The thickness of both sensors was 1 mm. The Timepix [26] USB2 readout system and the Pixelman [27] software from The Institute of Experimental and Applied Physics (IEAP) of Czech Technical University in Prague were used to control the chip.

A. Timepix

The Timepix [28] chip is developed by the Medipix2 [29] collaboration and is a hybrid pixel ASIC with single photon processing capability. The chip can be operated in either



Erik Fröidh, Rafael Ballabriga,
Xavier Llopert, Michael Campbell



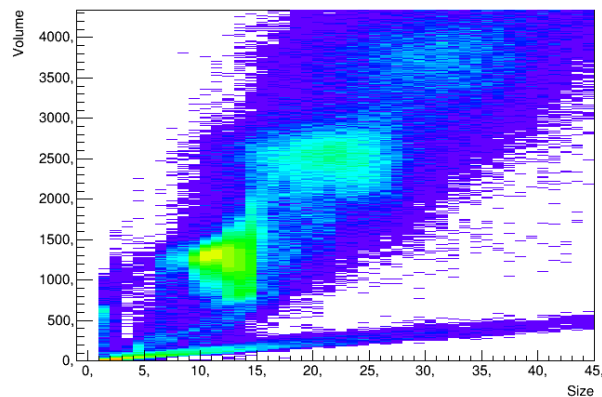
Medipix3RX Characterization

10/01/2013

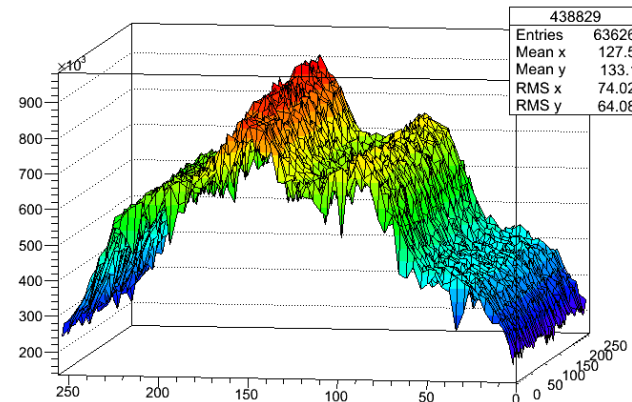
Medipix3 Open Meeting 30/1/2012

1

Characterization of Medipix3RX counters

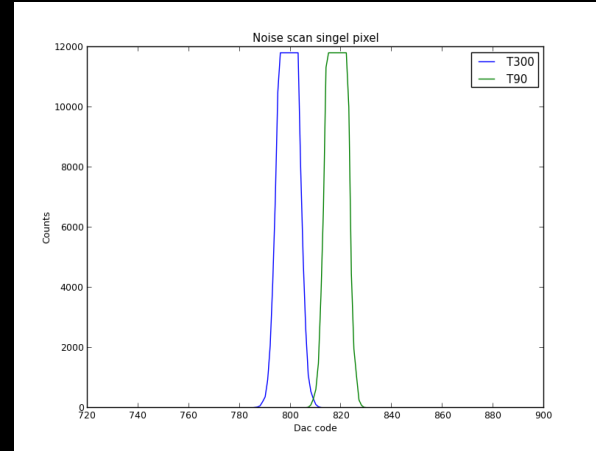


First measurements
with protons in Bern



Measurements of scattered
radiation and beam profile,
CHUV Lausanne.







Cocktailbar

49

RESTAURANT
PFERDEWIRTSCHAFT
ZUM LÖWEN

Steingasse

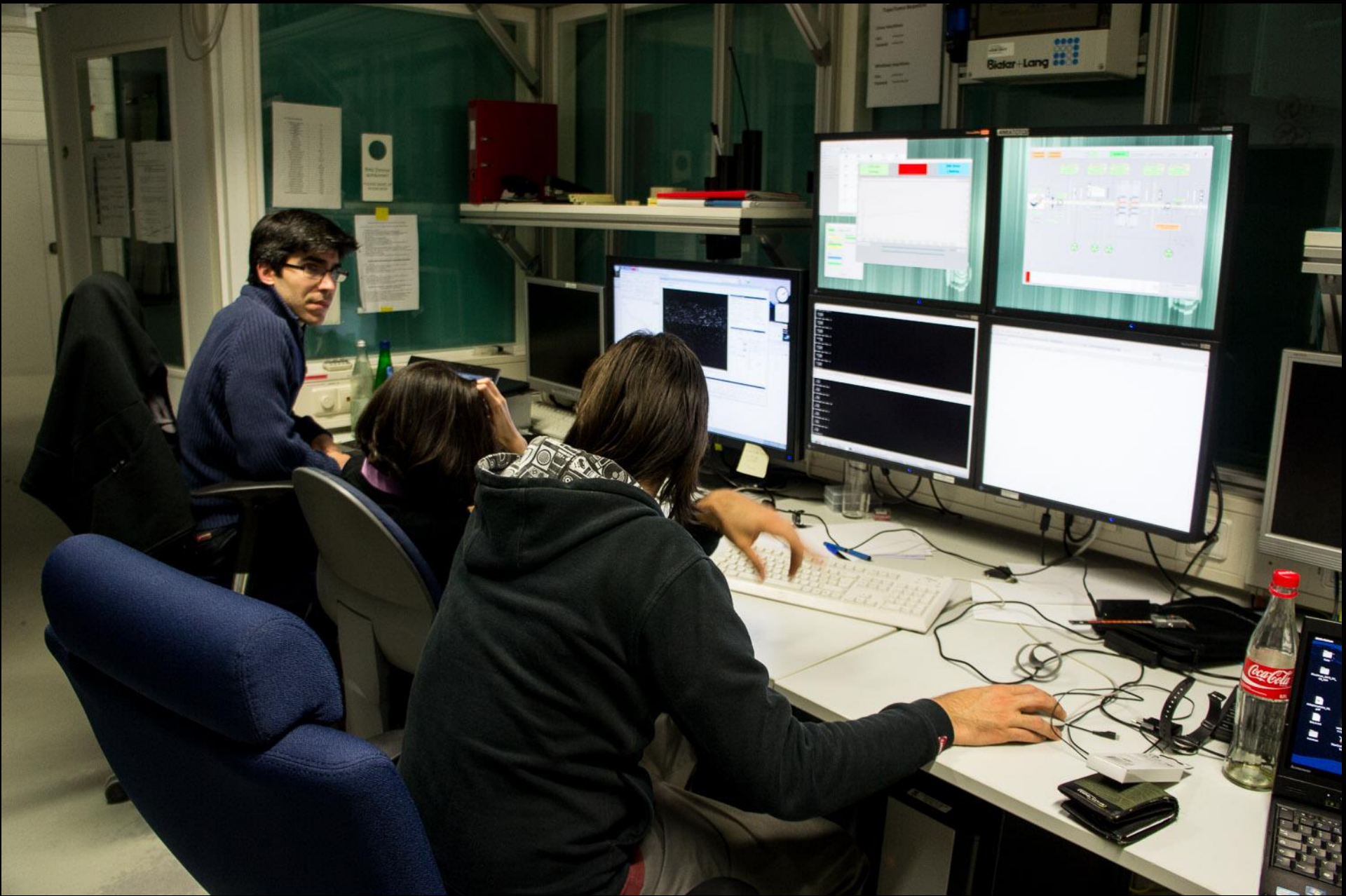
TOPO-TOMO

**Topographie
Tomographie**

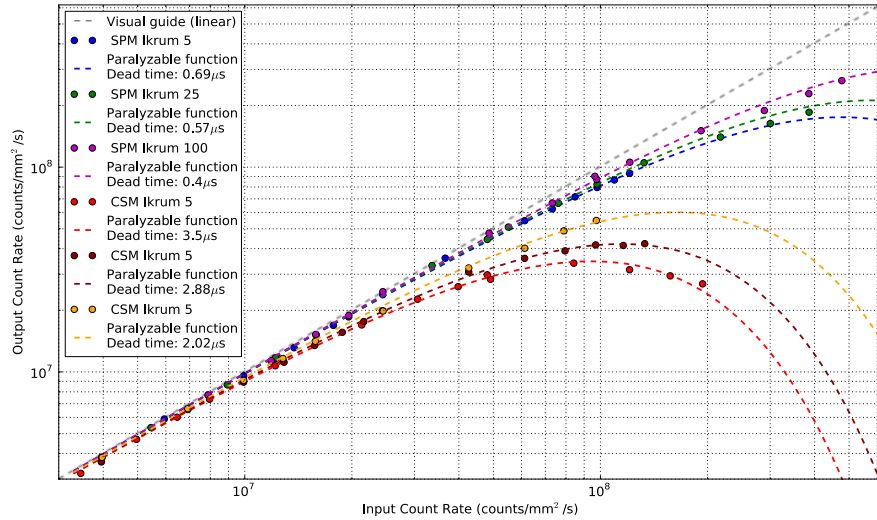
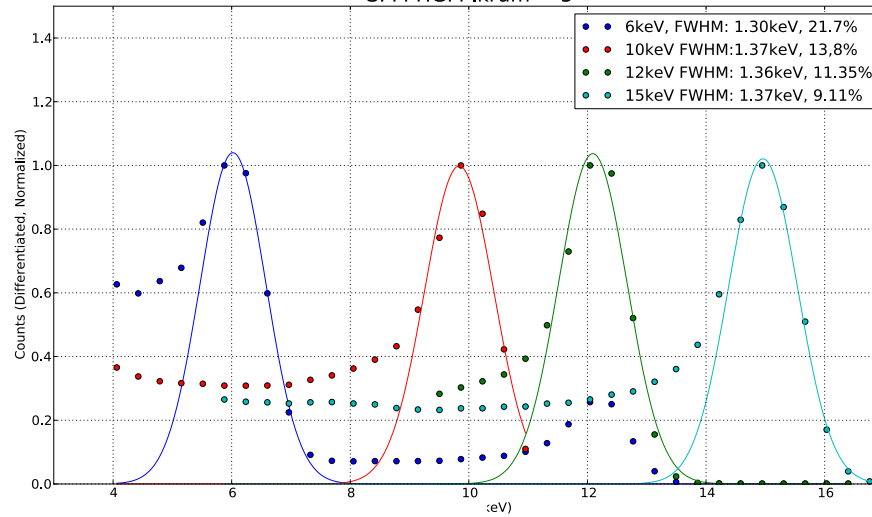
B3.1.1125



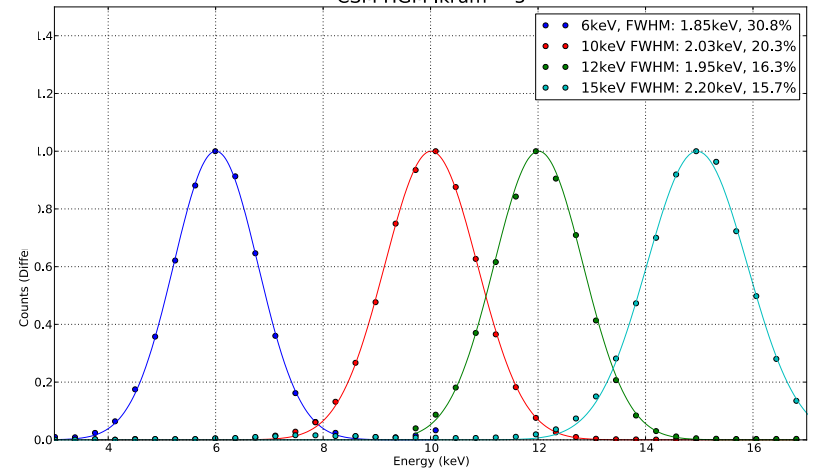




SPM HGM Ikrum = 5



CSM HGM Ikrum = 5





Publications

1. Frojdh, E.; et al., *Probing Defects in a Small Pixellated CdTe Sensor Using an Inclined Mono Energetic X-Ray Micro Beam*, *Nuclear Science, IEEE Transactions on* , vol.PP, no.99, pp.1,1, 0 doi: 10.1109/TNS.2013.2257851
2. D Krapohl et al, *Investigation of charge collection in a CdTe-Timepix detector 2013 JINST 8 C05003* [doi:10.1088/1748-0221/8/05/C05003](https://doi.org/10.1088/1748-0221/8/05/C05003)
3. FRÖJDH, C.; NORLIN, B.; FRÖJDH, E. Spectral X-ray imaging with single photon processing detectors. *Journal of Instrumentation*, 2013, 8.02: C02010.
4. BALLABRIGA, R., et al. The Medipix3RX: a high resolution, zero dead-time pixel detector readout chip allowing spectroscopic imaging. *Journal of Instrumentation*, 2013, 8.02: C02016.

Other Activities

Workshops

- Semiconductor Materials Simulation Workshop, Didcot UK

Courses

- French level 1, CERN
- Higher Education and Flexible learning (15ECTS) Mid Sweden University
- Semiconductor Devices (15ECTS), Mid Sweden University

Talks

- Medipix introduction at the Swiss radioprotection course
- Medipix overview, SMU Dallas
- Mid Time Seminar

Seminars

- Particle Therapy using Proton and Ion
- Introduction to Physics at CERN
- Various seminars in PH-ESE



ONE WAY

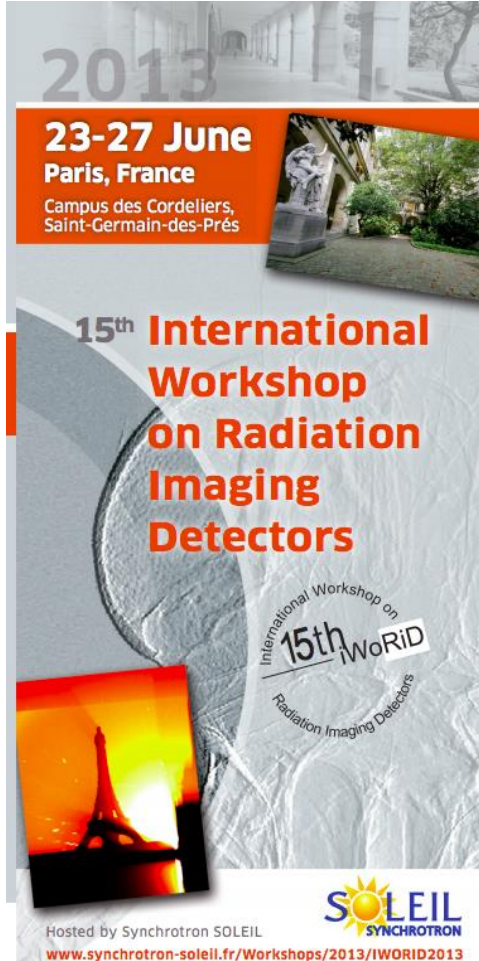



2013

23-27 June
Paris, France
 Campus des Cordeliers,
 Saint-Germain-des-Prés

**15th International
 Workshop
 on Radiation
 Imaging
 Detectors**

International Workshop on
15th iWoRiD
 Radiation Imaging Detectors

Hosted by Synchrotron SOLEIL
www.synchrotron-soleil.fr/Workshops/2013/IWORID2013

Institute of Electrical and Electronics Engineers

2013 IEEE NSS/MIC/RTSD

Nuclear Science Symposium & Medical Imaging Conference
 & Workshop on Room-Temperature Semiconductor X-Ray and Gamma-Ray Detectors

"Beyond Imagination of Future Science"

October 27 - November 2, COEX, Seoul, Korea
Abstract Submission Deadline: May 13, 2013

Radiation Detectors and Instrumentation for Nuclear, High-Energy, Space,
 Solid-State and Bio-Physics Applications, and Homeland Security
 Instrumentation and Methods for PET, SPECT, CT, MR, Optical, Multi-Modality
 and Application-Specific Medical Imaging, and Radiotherapy

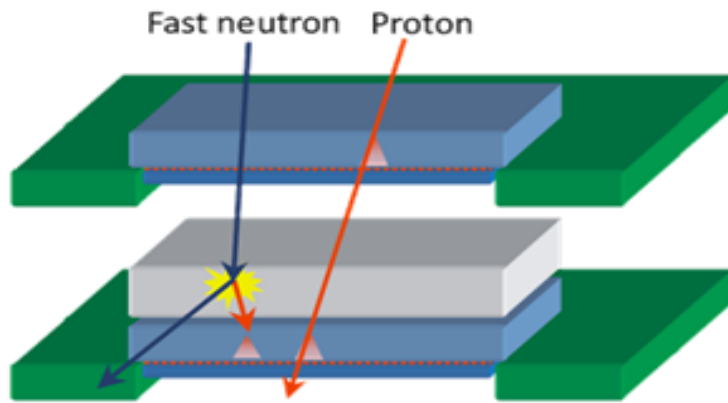
Plenary Sessions | Oral Sessions | Poster Sessions | Short Courses
Refresher Courses | Workshops | Industrial Exhibits | Companion Program

General Chair	Hye-Joung Kim	/ Yonsei University
Deputy General Chair	Steve Meikle	/ University of Sydney
NSS Chair	Gyuseong Cho	/ KAIST
NSS Deputy Chair	Ikuo Kanno	/ Kyoto University
MIC Chair	Jae Sung Lee	/ Seoul National University
MIC Deputy Chair	Craig Levin	/ Stanford University
RTSD Co-Chairs	Jang Ho Ha	/ KAERI
	Ralph James	/ Brookhaven National Laboratory

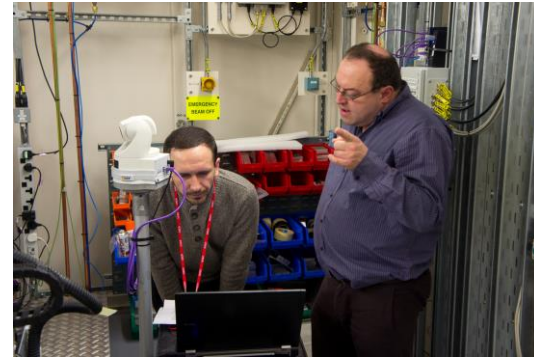
Homepage: www.nss-mic.org/2013 E-mail: nssmic2013@yonsei.ac.kr





Graphics Z. Vykydal



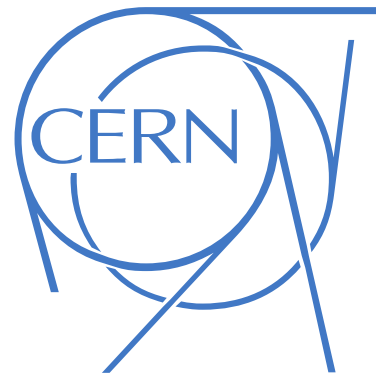
Timepix3

- Data driven
- Simultaneous ToT and ToaA
- 1.56ns timestamp





Advanced Radiation Dosimetry European Network Training



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BACKUP SLIDES

Experimental Activities

- Characterization of CdTe Sensors at Diamond Light Source (Measurements in May 2012 and March 2013)
- Characterization of Medipix3RX – Counter Upsets
- Characterization of Medipix3RX - High flux conditions
- Proton Measurements with Timepix Measurement in Bern
- Noise performance of Timepix cooled by LiN
- Count Rate Linearity and Energy response of Medipix3RX under high flux conditions at the ANKA synchrotron in Karlsruhe

Conferences and Presentations

- IEEE NSS/RTSD Conference Anaheim (Oral Presentation)
- Various meetings and workshops
 - Medipix meeting 19-20 September 2012 CERN
 - Medipix meeting 29-29 November 2012, CERN, (Oral Presentation)
 - Medipix meeting 30-31 January 2013, CERN, (Oral Presentation)
 - Detector Material Simulations Workshop 22 March, Didcot UK
 - Medipix meeting 5-6 June 2013 Freiburg, GE, (Oral Presentation)
- Planned
 - iWoRID 2013 Paris, (Poster)
 - NSS Seoul, (abstract submitted)
 - Medipix Meetings

Training Courses and Seminars

- Particle Therapy using Proton and Ion Beams - From Basic Principles to Daily Operations and Future Concepts
- Seminar - Introduction to Physics at CERN
- French level 1
- Seminars at The 1st ARDENT Workshop
- Higher Education and Flexible Learning (15ECTS)

Planned Activities

- iWoRID Conference June 2013
- Medipix3RX characterization measurements at Diamond Light Source, July 2013
- Abstract submitted to IEEE NSS Seoul
- Pre-study for a radiation monitor system using hybrid pixel detectors
- Characterization of Timepix3